

Notice of References Cited	Application/Control No. 10/787,213	Applicant(s)/Patent Under Reexamination WANG, CHIUNG-PIN	
	Examiner Wen-Ying P. Chen	Art Unit 2871	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,049,365	04-2000	Nakashima, Ken	349/42
	B	US-			
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FOREIGN PATENT DOCUMENTS

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